

RoHS Compliant Product
A suffix of "-C" specifies halogen and lead-free

DESCRIPTION

These miniature surface mount MOSFETs utilize a high cell density trench process to provide low $R_{DS(on)}$ and to ensure minimal power loss and heat dissipation.

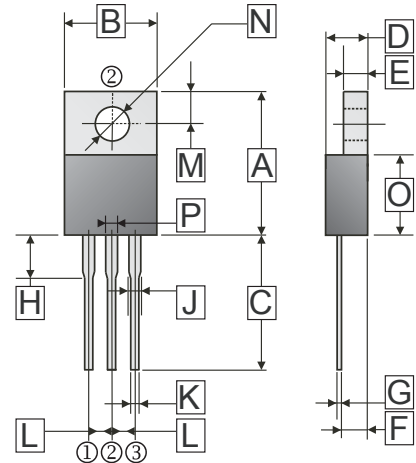
FEATURES

- Low $R_{DS(on)}$ provides higher efficiency and extends battery life.
- Low thermal impedance copper leadframe TO-220P saves board space.
- Fast Switch Speed.
- High performance trench technology.

APPLICATION

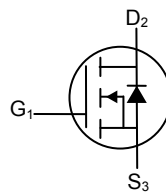
DC-DC converters and power management such as computers, printers, and power supplies .

TO-220P



Dimensions in millimeters

N-Channel



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	14.5	15.8	J	1.15	1.45
B	9.70	10.6	K	0.65	0.94
C	12.25	14.2	L	2.40	2.65
D	4.40	4.80	M	2.59	2.98
E	1.15	1.37	N	ϕ 3.7	ϕ 3.9
F	2.20	3.00	O	8.50	9.65
G	0.30	0.60	P	1.15	1.45
H	3.30	4.10			

ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V_{DS}	40	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ¹	I_D	90	A
	$T_C=25^\circ\text{C}$		
Pulsed Drain Current ²	I_{DM}	240	A
Continuous Source Current (Diode Conduction) ¹	I_S	90	A
Power Dissipation ¹	P_D	300	W
	$T_C=25^\circ\text{C}$		
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55~175	$^\circ\text{C}$
Thermal Resistance Rating			
Maximum Junction to Ambient ¹	$R_{\theta JA}$	62.5	$^\circ\text{C} / \text{W}$
Maximum Junction to Case	$R_{\theta JC}$	0.5	

Notes:

- 1 Package Limited.
- 2 Pulse width limited by maximum junction temperature.

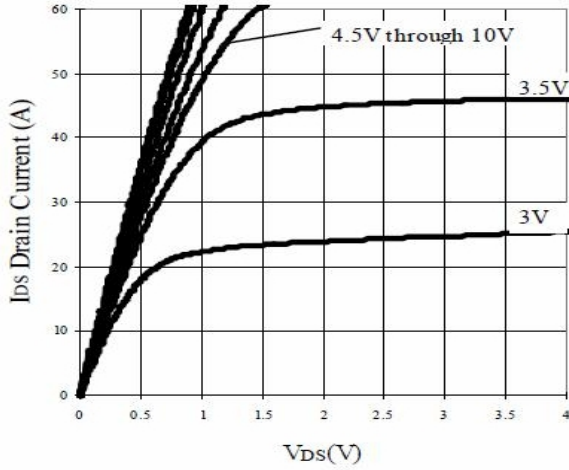
ELECTRICAL CHARACTERISTICS ($T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static						
Gate-Threshold Voltage	$V_{GS(th)}$	1	-	-	V	$V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$
Gate-Body Leakage	I_{GSS}	-	-	± 100	nA	$V_{DS}=0$, $V_{GS}=20\text{V}$
Zero Gate Voltage Drain Current	I_{DSS}	-	-	1	μA	$V_{DS}=32\text{V}$, $V_{GS}=0$
		-	-	25		$V_{DS}=32\text{V}$, $V_{GS}=0$, $T_J=55^\circ\text{C}$
On-State Drain Current ¹	$I_{D(on)}$	120	-	-	A	$V_{DS}=5\text{V}$, $V_{GS}=10\text{V}$
Drain-Source On-Resistance ¹	$R_{DS(ON)}$	-	-	5	m Ω	$V_{GS}=10\text{V}$, $I_D=30\text{A}$
		-	-	7.5		$V_{GS}=4.5\text{V}$, $I_D=20\text{A}$
Forward Transconductance ¹	g_{fs}	-	30	-	S	$V_{DS}=15\text{V}$, $I_D=30\text{A}$
Diode Forward Voltage	V_{SD}	-	1.1	-	V	$I_S=34\text{A}$, $V_{GS}=0$
Dynamic ²						
Total Gate Charge	Q_g	-	4	-	nC	$V_{DS}=15\text{V}$, $V_{GS}=4.5\text{V}$, $I_D=90\text{A}$
Gate-Source Charge	Q_{gs}	-	1.1	-		
Gate-Drain Charge	Q_{gd}	-	1.4	-		
Turn-on Delay Time	$T_{d(on)}$	-	16	-	nS	$V_{DD}=25\text{V}$, $V_{GEN}=10\text{V}$, $R_L=25\Omega$, $I_D=34\text{A}$
Rise Time	T_r	-	5	-		
Turn-off Delay Time	$T_{d(off)}$	-	23	-		
Fall Time	T_f	-	3	-		

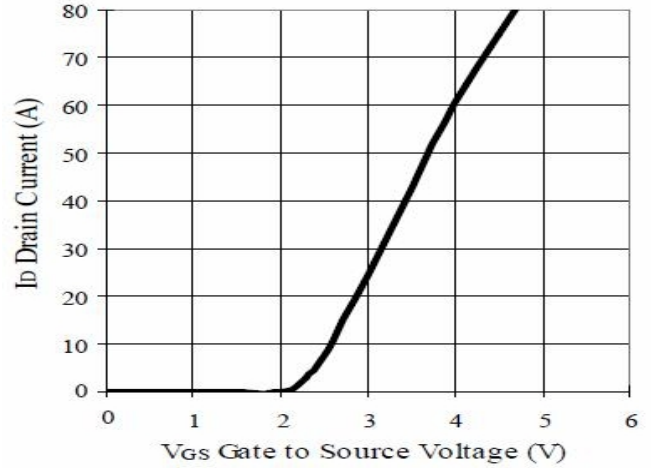
Notes:

- 1 Pulse test : $PW \leq 300 \mu\text{s}$ duty cycle $\leq 2\%$.
- 2 Guaranteed by design, not subject to production testing.

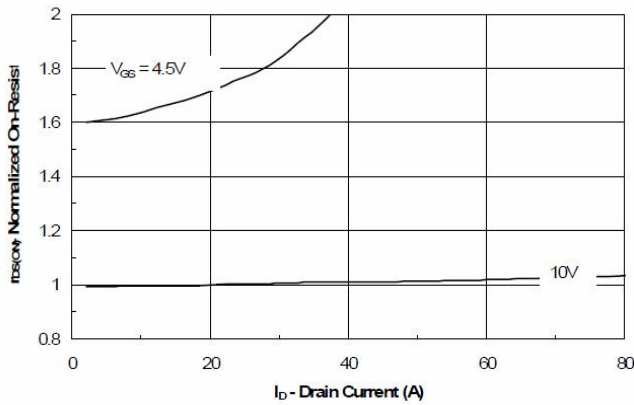
CHARACTERISTIC CURVES



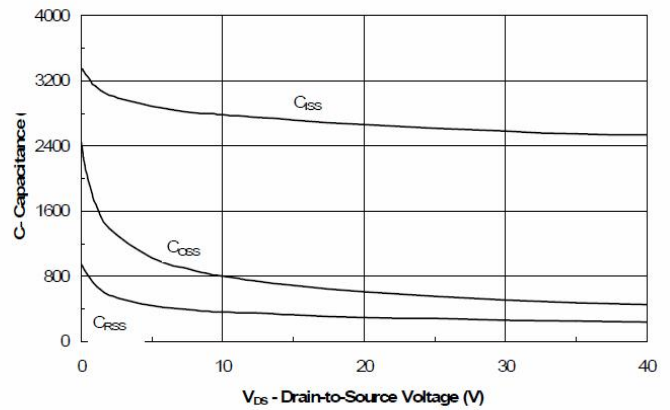
Output Characteristics



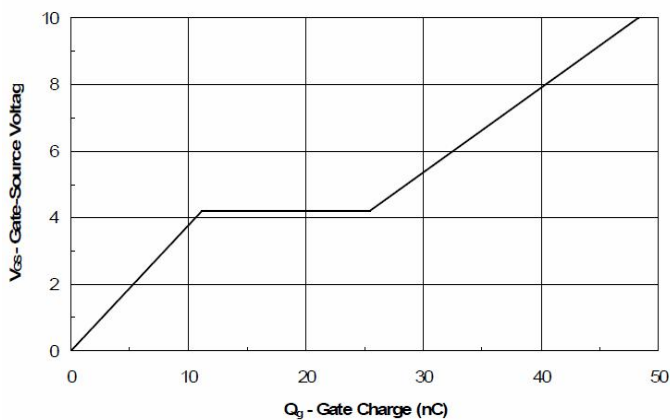
Transfer Characteristics



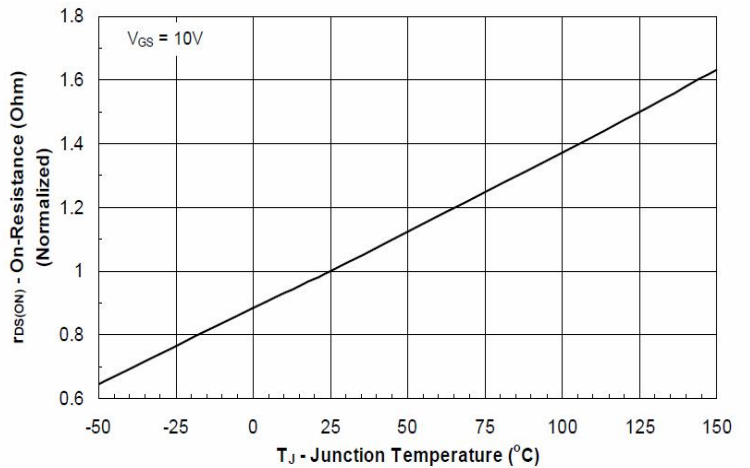
On Resistance vs. Drain Current



Capacitance

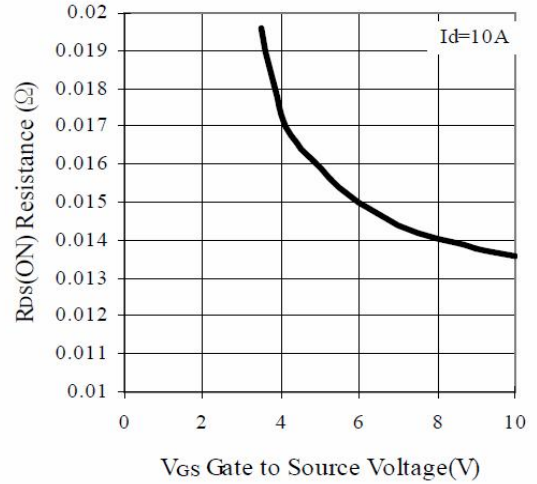
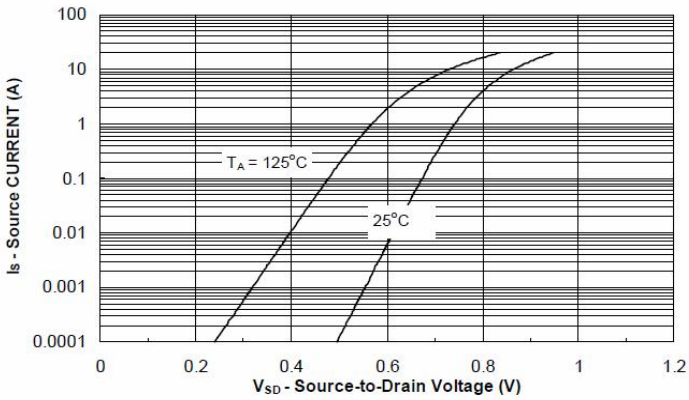


Gate Charge

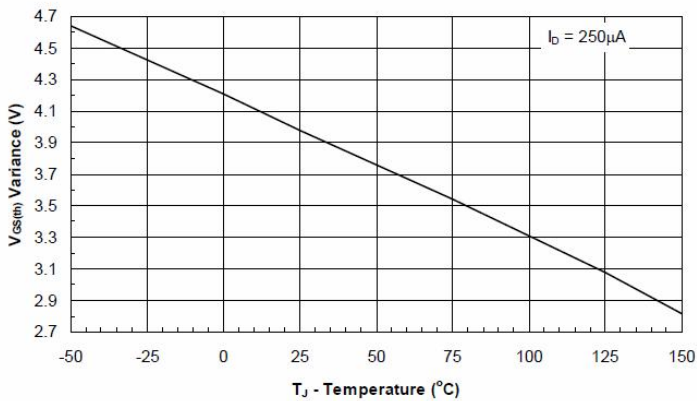


On-Resistance vs. Junction Temperature

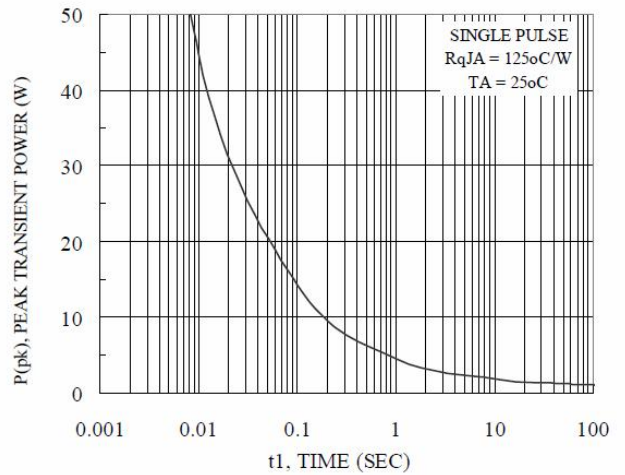
CHARACTERISTIC CURVES



Source-Drain Diode Forward Voltage



On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

Figure 10. Single Pulse Maximum Power Dissipation

Normalized Thermal Transient Junction to Ambient

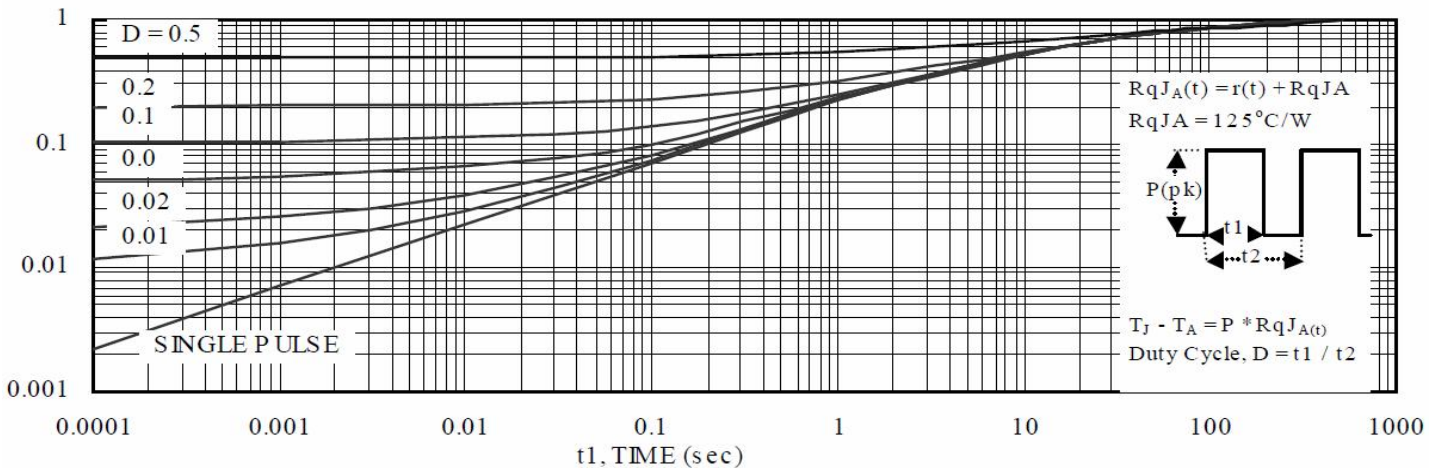


Figure 11. Transient Thermal Response Curve